



●Electrical characteristics (Ta = 25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Gate-source leakage	$I_{GSS}$	—	—	$\pm 10$	$\mu A$	$V_{GS} = \pm 20V, V_{DS} = 0V$
Drain-source breakdown voltage	$V_{(BR)DSS}$	60	—	—	V	$I_D = 1mA, V_{GS} = 0V$
Zero gate voltage drain current	$I_{DSS}$	—	—	10	$\mu A$	$V_{DS} = 60V, V_{GS} = 0V$
Gate threshold voltage	$V_{GS(th)}$	0.8	—	1.5	V	$V_{DS} = 10V, I_D = 1mA$
Static drain-source on-state resistance	$R_{DS(on)}$	—	0.25	0.32	$\Omega$	$I_D = 1A, V_{GS} = 4V$
	$R_{DS(on)}$	—	0.35	0.45	$\Omega$	$I_D = 1A, V_{GS} = 2.5V$
Forward transfer admittance	$ Y_{fs} ^*$	1.5	—	—	S	$I_D = 1A, V_{DS} = 10V$
Input capacitance	$C_{iss}$	—	160	—	pF	$V_{DS} = 10V$
Output capacitance	$C_{oss}$	—	85	—	pF	$V_{GS} = 0V$
Reverse transfer capacitance	$C_{rss}$	—	25	—	pF	$f = 1MHz$
Turn-on delay time	$t_{d(on)}$	—	20	—	ns	$I_D = 1A, V_{DD} \approx 30V$
Rise time	$t_r$	—	50	—	ns	$V_{GS} = 4V$
Turn-off delay time	$t_{d(off)}$	—	120	—	ns	$R_L = 30\Omega$
Fall time	$t_f$	—	70	—	ns	$R_G = 10\Omega$

\*  $P_w \leq 300 \mu s, \text{Duty cycle} \leq 1\%$

●Packaging specifications

Type	Package	Taping
	Code	T100
	Basic ordering unit (pieces)	1000
2SK3065		○

●Electrical characteristic curves

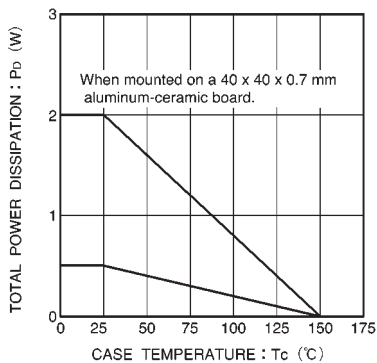


Fig.1 Total power dissipation vs. case temperature

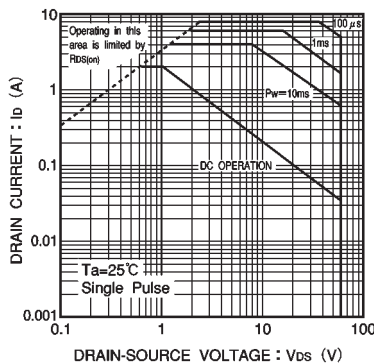


Fig.2 Maximum safe operating area

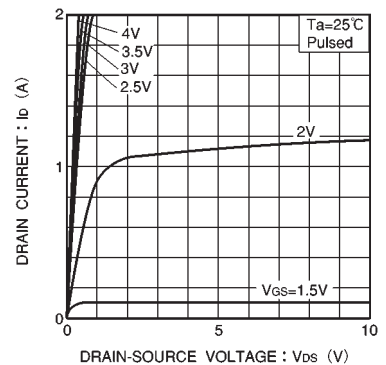


Fig.3 Typical output characteristics

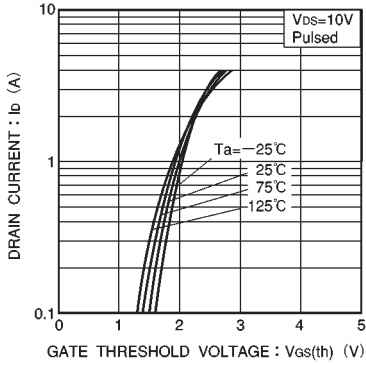


Fig.4 Typical transfer characteristics

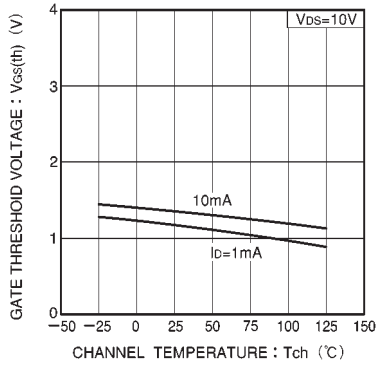


Fig.5 Gate threshold voltage vs. channel temperature

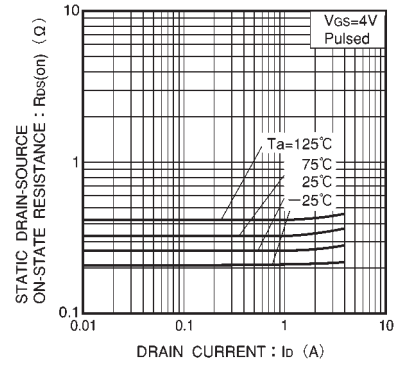


Fig.6 Static drain-source on-state resistance vs. drain current ( I )

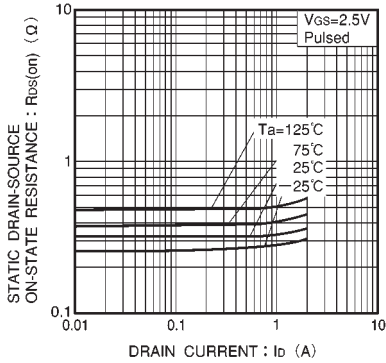


Fig.7 Static drain-source on-state resistance vs. drain current ( II )

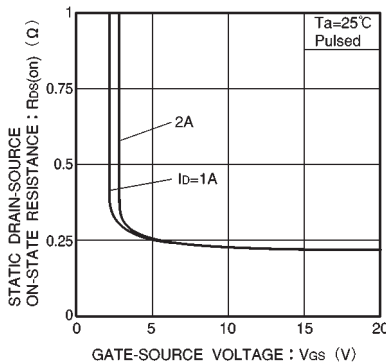


Fig.8 Static drain-source on-state resistance vs. gate-source voltage

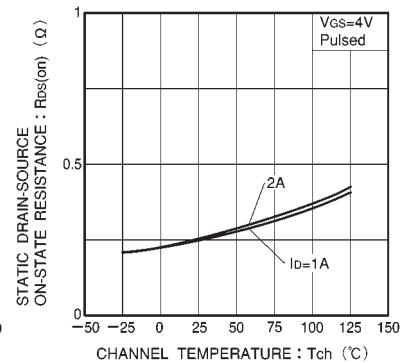


Fig.9 Static drain-source on-state resistance vs. channel temperature

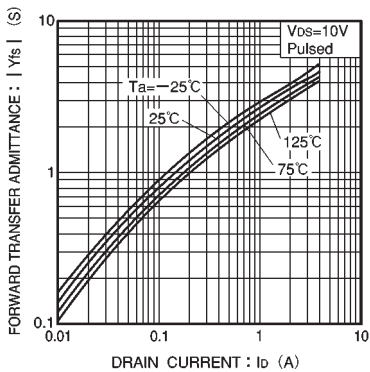


Fig.10 Forward transfer admittance vs. drain current

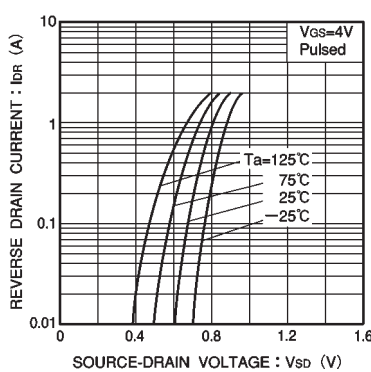


Fig.11 Reverse drain current vs. source-drain voltage ( I )

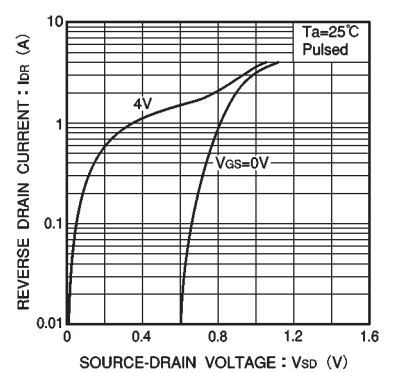


Fig.12 Reverse drain current vs. source-drain voltage ( II )

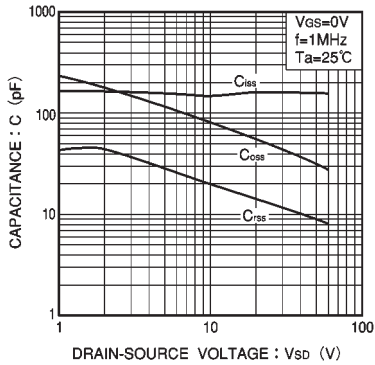


Fig.13 Typical capacitance vs. drain-source voltage

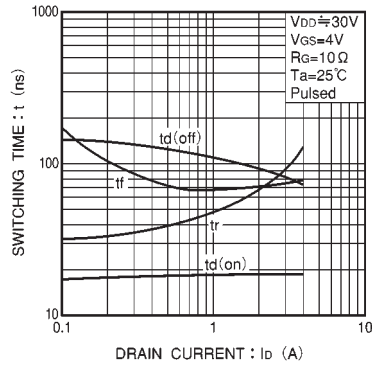


Fig.14 Switching characteristics (See Figures 17 and 18 for the measurement circuit and resultant waveforms)

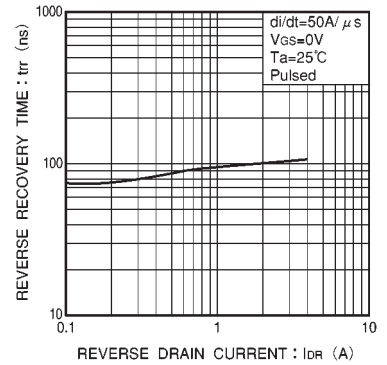


Fig.15 Reverse recovery time vs. reverse drain current

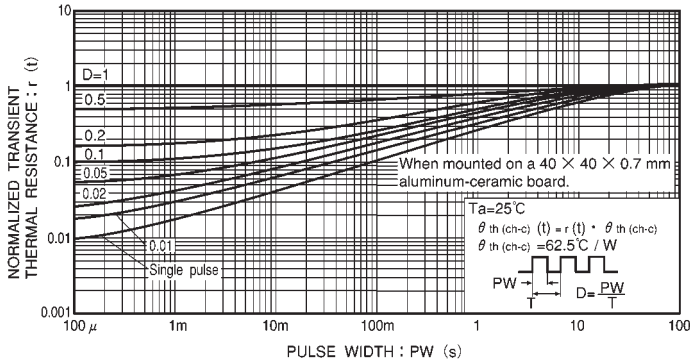


Fig.16 Normalized transient thermal resistance vs. pulse width

● Switching characteristics measurement circuit

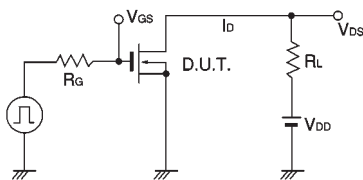


Fig17 Switching time measurement circuit

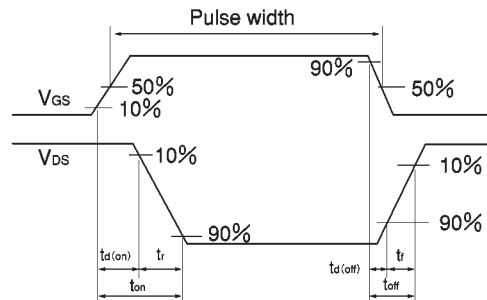


Fig18 Switching time waveforms